



FQD2P40 / FQU2P40

400V P-Channel MOSFET

General Description

These P-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

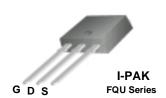
This advanced technology is especially tailored to minimize on-state resistance, provide superior switching performance, and withstand a high energy pulse in the avalanche and commutation modes. These devices are well suited for electronic lamp ballasts based on the complementary half bridge topology.

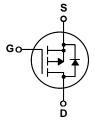
Features

- -1.56A, -400V, $R_{DS(on)} = 6.5\Omega$ @ $V_{GS} = -10 \text{ V}$
- Low gate charge (typical 10 nC)
- Low Crss (typical 6.5 pF)
- Fast switching
- 100% avalanche tested
- · Improved dv/dt capability
- · RoHS Compliant









Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter		FQD2P40 / FQU2P40	Units
V _{DSS}	Drain-Source Voltage		-400	V
I _D	Drain Current - Continuous (T _C = 25°C	C)	-1.56	А
	- Continuous (T _C = 100°	- Continuous (T _C = 100°C)		А
I _{DM}	Drain Current - Pulsed	(Note 1)	-6.24	А
V _{GSS}	Gate-Source Voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	120	mJ
I _{AR}	Avalanche Current	(Note 1)	-1.56	А
E _{AR}	Repetitive Avalanche Energy	(Note 1)	3.8	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	-4.5	V/ns
P _D	Power Dissipation (T _A = 25°C) *		2.5	W
_	Power Dissipation (T _C = 25°C)		38	W
	- Derate above 25°C		0.3	W/°C
T_J , T_{STG}	Operating and Storage Temperature Range		-55 to +150	°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

Thermal Characteristics

* When mounted on the minimum pad size recommended (PCB Mount)

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		3.29	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		50	°C/W
R _{0JA} Thermal Resistance, Junction-to-Ambient			110	°C/W

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Cha	aracteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-400			V
ΔBV _{DSS} / ΔΤ _J	Breakdown Voltage Temperature Coefficient	I _D = -250 μA, Referenced to 25°C		-		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = -400 V, V _{GS} = 0 V			-1	μΑ
		V _{DS} = -320 V, T _C = 125°C			-10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = -30 V, V _{DS} = 0 V			-100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = 30 V, V _{DS} = 0 V			100	nA
On Cha	racteristics					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$	-3.0		-5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	$V_{GS} = -10 \text{ V}, I_D = -0.78 \text{ A}$	-	5.0	6.5	Ω
9 _{FS}	Forward Transconductance	$V_{DS} = -50 \text{ V}, I_D = -0.78 \text{ A}$ (Note 4)		1.26		S
C _{iss}	Input Capacitance Output Capacitance	$V_{DS} = -25 \text{ V, } V_{GS} = 0 \text{ V,}$ f = 1.0 MHz		270 45	350 60	pF pF
C _{rss}	Reverse Transfer Capacitance			6.5	8.5	pF
Switchi	ng Characteristics		1			
t _{d(on)}	Turn-On Delay Time	V _{DD} = -200 V, I _D = -2.0 A,		9	30	ns
t _r	Turn-On Rise Time	$R_G = 25 \Omega$		33	75	ns
t _{d(off)}	Turn-Off Delay Time			22	55	ns
t _f	Turn-Off Fall Time	(Note 4, 5)		25	60	ns
Q_g	Total Gate Charge	$V_{DS} = -320 \text{ V}, I_{D} = -2.0 \text{ A},$		10	13	nC
Q_{gs}	Gate-Source Charge	V _{GS} = -10 V		2.1		nC
Q_{gd}	Gate-Drain Charge	(Note 4, 5)		5.5		nC
Drain-S	ource Diode Characteristics ar	nd Maximum Ratings				
I _S	Maximum Continuous Drain-Source Diode Forward Current				-1.56	Α
I _{SM}	Maximum Pulsed Drain-Source Diode F				-6.24	Α
V _{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = -1.56 \text{ A}$			-5.0	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 \text{ V, } I_S = -2.0 \text{ A,}$		250		ns
Q_{rr}	Reverse Recovery Charge	$dI_F / dt = 100 A/\mu s$ (Note 4)		0.85		μC

- $\label{eq:Notes:Notes:1} \begin{array}{ll} \textbf{Notes:} \\ \textbf{1.} \ \ \text{Repetitive Rating: Pulse width limited by maximum junction temperature} \\ \textbf{2.} \ \ \textbf{L} = 86\text{mH, } \ \textbf{I}_{AS} = -1.56\text{A, } \ \textbf{V}_{DD} = -50\text{V, } \ \textbf{R}_{G} = 25\ \Omega, \ \text{Starting} \ \ \textbf{T}_{J} = 25^{\circ}\text{C} \\ \textbf{3.} \ \ \textbf{I}_{SD} \leq -2.0\text{A, } \ \text{di/dt} \leq 200\text{A/µs, } \ \textbf{V}_{DD} \leq \text{BV}_{DS}, \ \text{Starting} \ \ \textbf{T}_{J} = 25^{\circ}\text{C} \\ \textbf{4.} \ \ \text{Pulse Test: Pulse width} \leq 300\text{µs, } \ \text{Duty cycle} \leq 2\% \\ \textbf{5.} \ \ \ \text{Essentially independent of operating temperature} \\ \end{array}$

Typical Characteristics

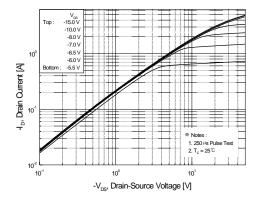


Figure 1. On-Region Characteristics

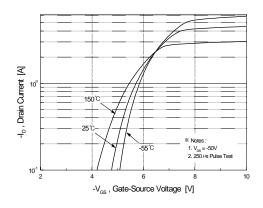


Figure 2. Transfer Characteristics

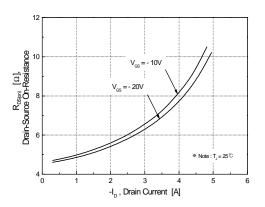


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

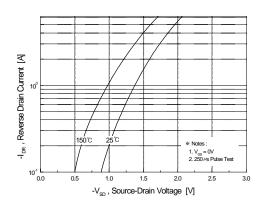


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

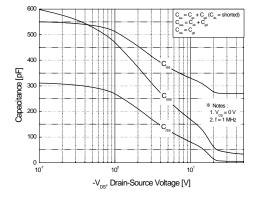


Figure 5. Capacitance Characteristics

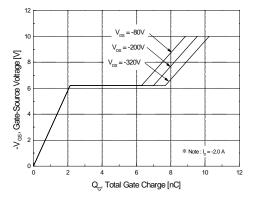
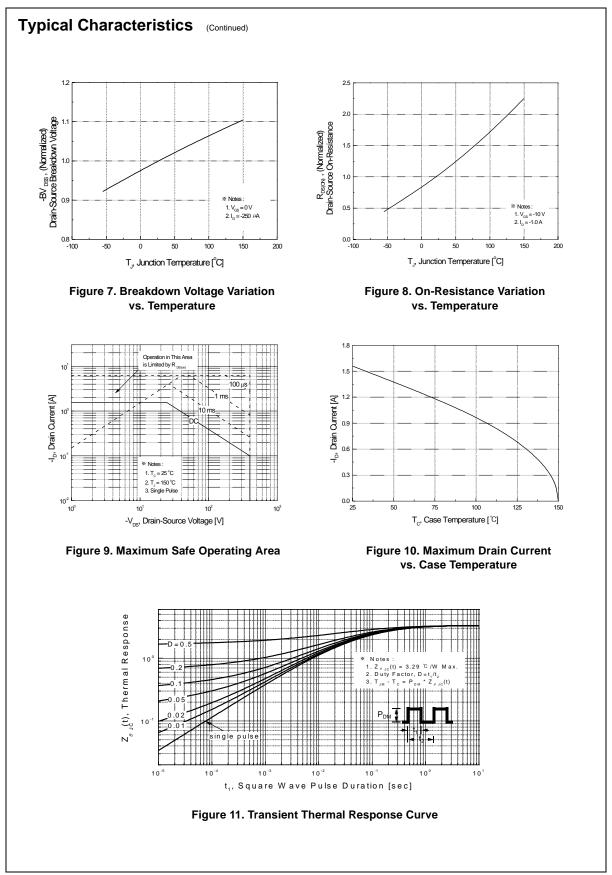
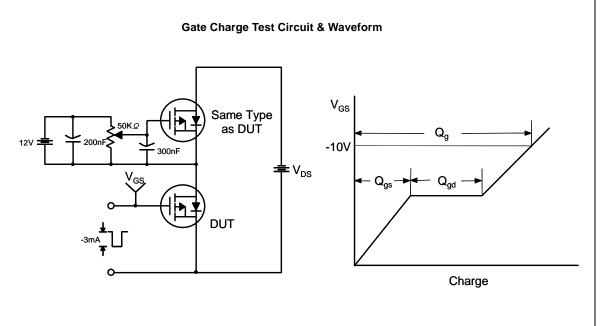
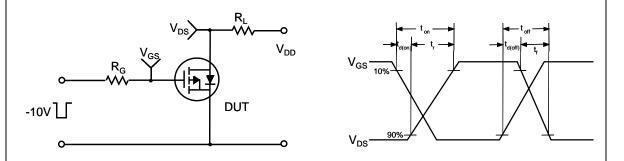


Figure 6. Gate Charge Characteristics

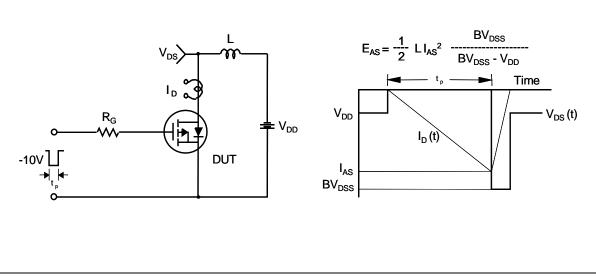




Resistive Switching Test Circuit & Waveforms

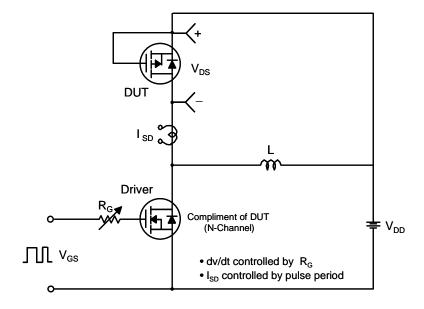


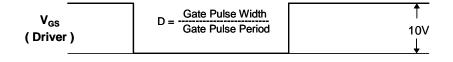
Unclamped Inductive Switching Test Circuit & Waveforms



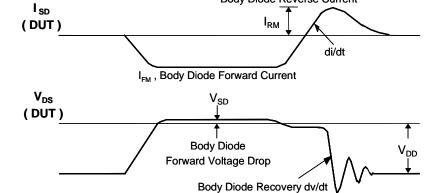
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Peak Diode Recovery dv/dt Test Circuit & Waveforms



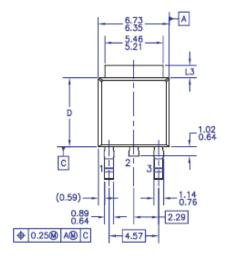


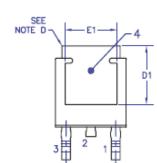
Body Diode Reverse Current

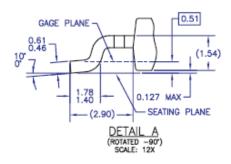


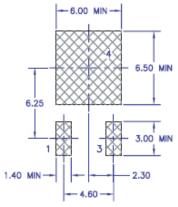
Mechanical Dimensions

D - PAK

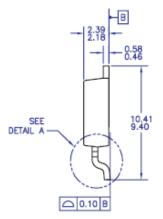








LAND PATTERN RECOMMENDATION



Dimensions in Millimeters

Mechanical Dimensions I - PAK ►A. 6.80 6.35 2.50 2.10 5.54 5.14 1.27 0.50 0.60 0.40 - 1.52 0.70 - 2.28 - 1.60 ď 3 9.65 8.90 - 1.14 0.90 (0.60) -2.29 0.60 0.88 0.64 ⊕ 0.25 M AM C 3 PLCS Dimensions in Millimeters





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